TOSHIBA Field Effect Transistor Silicon N Channel MOS Type

# **SSM3K316T**

**Power Management Switch Applications** 

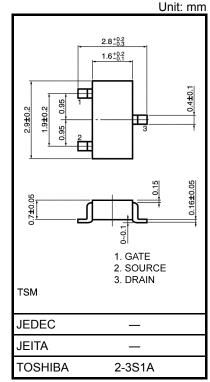
**High-Speed Switching Applications** 

- 1.8-V drive
- Low ON-resistance:  $R_{on} = 131 \text{ m}\Omega \text{ (max)} (@V_{GS} = 1.8 \text{ V})$

#### Absolute Maximum Ratings (Ta = 25°C)

| Characteristics           |       | Symbol                   |          | Rating     | Unit  |  |
|---------------------------|-------|--------------------------|----------|------------|-------|--|
| Drain-source voltage      |       | V <sub>DSS</sub>         |          | 30         | V     |  |
| Gate-source voltage       |       | V <sub>GSS</sub>         |          | ± 12       | V     |  |
| Drain current             | DC    | ID                       | (Note 1) | 4.0        | А     |  |
|                           | Pulse | I <sub>DP</sub> (Note 1) |          | 8.0        | A     |  |
| Drain power dissipation   |       | P <sub>D</sub> (Note 2)  |          | 700        | mW    |  |
|                           |       |                          | t = 10s  | 1250       | IIIVV |  |
| Channel temperature       |       | T <sub>ch</sub>          |          | 150        | °C    |  |
| Storage temperature range |       | T <sub>stg</sub>         |          | –55 to 150 | °C    |  |

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).



Weight: 10 mg (typ.)

| Note 1: The Junction temperature sh | ould not exceed 150°C during use.   |
|-------------------------------------|---|
| Note 2: Mounted on an FR4 board.    | $(25.4 \text{ mm} \times 25.4 \text{ mm} \times 1.6 \text{ mm}, \text{ Cu Pad: } 645 \text{ mm}^2)$ |

#### Electrical Characteristics (Ta = 25°C)

| Charac                         | teristics                                     | Symbol           | Test Condition   |         | Min | Тур.  | Max   | Unit |
|--------------------------------|---|------------------|--|---------|-----|-------|-------|------|
| Drain-source breakdown voltage |   | V (BR) DSS       | $I_D = 1 \text{ mA}, V_{GS} = 0 \text{ V}$               |         | 30  |       | _     | V    |
|                                |   | V (BR) DSX       | $I_D = 1 \text{ mA}, V_{GS} = -12 \text{ V}$             |         | 18  |       | _     | V    |
| Drain cutoff currer            | nt  | I <sub>DSS</sub> | $V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$    |         | _   |       | 1     | μA   |
| Gate leakage curr              | ent   | I <sub>GSS</sub> | $V_{GS}=\pm~12~V,~V_{DS}=0~V$                            |         | _   |       | ±1    | μA   |
| Gate threshold vol             | Itage   | V <sub>th</sub>  | $V_{DS} = 3 V, I_D = 1 mA$                               |         | 0.4 |       | 1.0   | V    |
| Forward transfer a             | admittance                                    | Y <sub>fs</sub>  | $V_{DS} = 3 V, I_D = 2 A$                                | (Note3) | 3.8 | 7.7   |       | S    |
|                                |   | Rds (ON)         | I <sub>D</sub> = 3.0 A, V <sub>GS</sub> = 10V            | (Note3) |     | 42    | 53    | mΩ   |
|                                | $I_D = 2.0 \text{ A}, V_{GS} = 4.5 \text{ V}$ |                  | (Note3)  | _       | 51  | 65    |       |      |
| Drain-source ON-resistance     |   |                  | I <sub>D</sub> = 1.0 A, V <sub>GS</sub> = 2.5 V          | (Note3) | _   | 64    | 87    |      |
|                                |   |                  | $I_D = 0.5 \text{ A}, V_{GS} = 1.8 \text{ V}$            | (Note3) | _   | 81    | 131   |      |
| Input capacitance              |   | C <sub>iss</sub> | V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz |         | _   | 270   | _     | pF   |
| Output capacitance             |   | C <sub>oss</sub> |  |         | _   | 56    |       |      |
| Reverse transfer capacitance   |   | C <sub>rss</sub> |  | _       | 47  |       |       |      |
| Total Gate Charge              |   | Qg               |  |         | _   | 4.3   | _     |      |
| Gate-Source Charge             |   | Q <sub>gs</sub>  | $V_{DS} = 15 \text{ V}, \text{ I}_{DS} = 3.0 \text{ A}$  |         |     | 2.8   |       | nC   |
| Gate-Drain Charge              |   | Q <sub>gd</sub>  | $V_{GS} = 4 V$   |         | _   | 1.5   |       |      |
| Switching time                 | Turn-on time                                  | t <sub>on</sub>  | $V_{DD} = 10 \text{ V}, \text{ I}_{D} = 2 \text{ A},$    |         |     | 20    | _     | 20   |
|                                | Turn-off time                                 | t <sub>off</sub> | $V_{GS}$ = 0 to 2.5 V, $R_{G}$ = 4.7 $\Omega$            |         | _   | 31    |       | ns   |
| Drain-source forward voltage   |   | V <sub>DSF</sub> | $I_D = -4.0 \text{ A}, V_{GS} = 0 \text{ V}$             | (Note3) |     | - 0.9 | - 1.2 | V    |

Note3: Pulse test

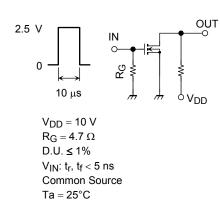
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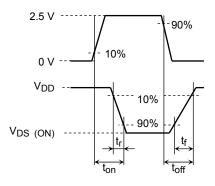
### Switching Time Test Circuit

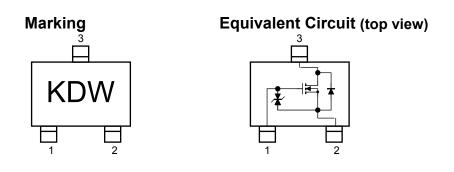
(a) Test Circuit

(b) V<sub>IN</sub>

(c) V<sub>OUT</sub>







#### **Usage Considerations**

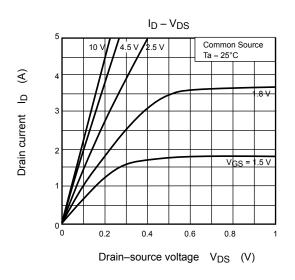
Let  $V_{th}$  be the voltage applied between gate and source that causes the drain current (I<sub>D</sub>) to below 1 mA for the SSM3K316T). Then, for normal switching operation,  $V_{GS(on)}$  must be higher than  $V_{th}$ , and  $V_{GS(off)}$  must be lower than  $V_{th}$ . This relationship can be expressed as:  $V_{GS(off)} < V_{th} < V_{GS(on)}$ .

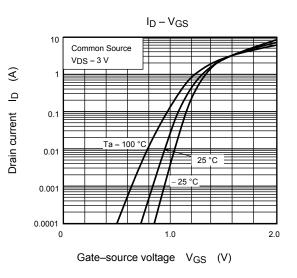
Take this into consideration when using the device.

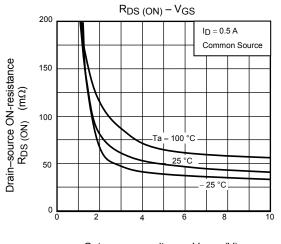
#### **Handling Precaution**

When handling individual devices that are not yet mounted on a circuit board, make sure that the environment is protected against electrostatic discharge. Operators should wear antistatic clothing, and containers and other objects that come into direct contact with devices should be made of antistatic materials.

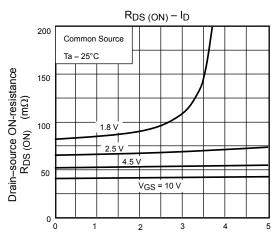
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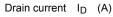


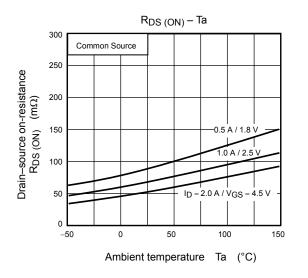


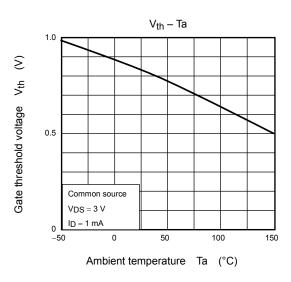


Gate–source voltage  $V_{GS}$  (V)

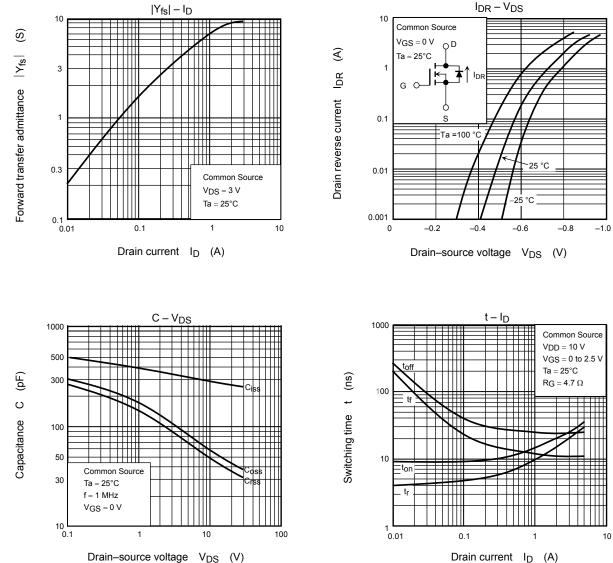




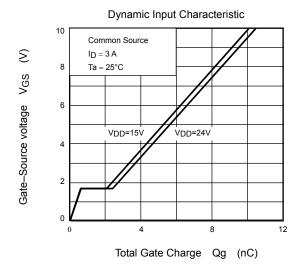




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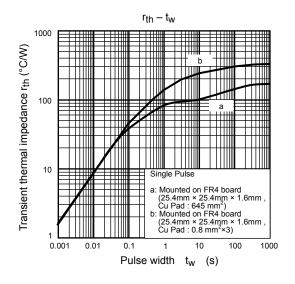


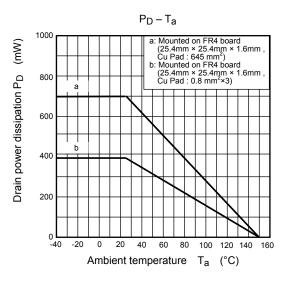
Drain current ID (A)



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